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( Not for submission under 37 CFR 1.99)

Application Number	10757237
Filing Date	2004-01-14
First Named Inventor	DeWitt, Jr. et al.
Art Unit	2181
Examiner Name	Lai, Vincent
Attorney Docket Number	AUS920030550US1

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W	2	4316245		1982-02-16	Luu et al.	
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W	5	5950003		1999-09-30	Kaneshiro et al.	
W	6	5212794		1993-05-18	Pettis et al.	
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W	8	6006033		1999-12-21	Heisch	

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W	17	5950003		1999-09-07	Kaneshiro et al.	
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